Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	-
10/718,192	KUO ET AL.	
Examiner	Art Unit	
Chris C. Chu	2815	

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	SEAR	CHED	
Class	Subclass	Date	Examiner
257	723	3/16/2005	C.C.
508	161	3/16/2005	C.C.

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	1		

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
Searched in US-PGPUB; USPAT; EPO; JPO; DERWENT; and IBM_TDB;	3/16/2005	c.c.